



Let Performance Drive

CMD213

30-40 GHz Active Frequency Doubler

Features

- ▶ High output power
- ▶ Excellent Fo isolation
- ▶ Broadband performance
- ▶ Small die size

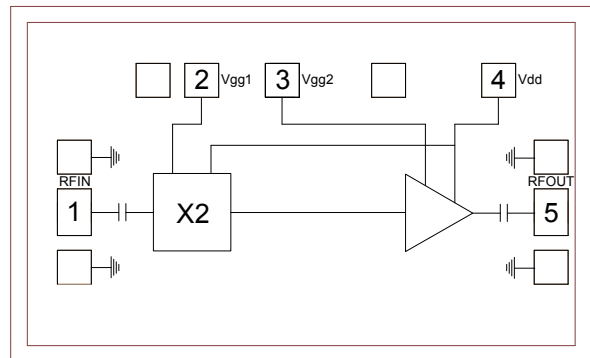
Applications

- ▶ Point-to-point radios
- ▶ Point-to-multi-point radios
- ▶ Military and space
- ▶ Test instrumentation

Description

The CMD213 die is a broadband MMIC GaAs x2 active frequency multiplier. When driven by a +17dBm signal, the multiplier provides +17 dBm output power from 30 to 40 GHz. The Fo isolation is greater than 46 dBc at 35 GHz. The CMD213 is a 50 ohm matched design eliminating the need for external DC blocks and RF port matching.

Functional Block Diagram



Electrical Performance - $V_{dd} = 5\text{ V}$, $V_{gg1} = -1.8\text{ V}$, $V_{gg2} = -0.7\text{ V}$, $T_A = 25\text{ }^\circ\text{C}$, $P_{in} = 17\text{ dBm}$

Parameter	Min	Typ	Max	Units
Frequency Range, Input	15 - 20			GHz
Frequency Range, Output	30 - 40			GHz
Output Power		17		dBm
Fo Isolation (with respect to output level)		46		dBc
Input Return Loss		15		dB
Output Return Loss		7		dB
Supply Current		55		mA

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Specifications

Absolute Maximum Ratings

Parameter	Rating
Drain Voltage, Vdd	6.0 V
RF Input Power	+20 dBm
Channel Temperature, Tch	150 °C
Power Dissipation, P _{diss}	317 mW
Thermal Resistance	205 °C/W
Operating Temperature	-55 to 85 °C
Storage Temperature	-55 to 150 °C

Operation of this device outside the maximum ratings may cause permanent damage.

Recommended Operating Conditions

Parameter	Min	Typ	Max	Units
Vdd	3.0	5.0	5.5	V
I _{dd}		55		mA
V _{gg1}		-1.8		V
V _{gg2}		-0.7		V

Electrical performance is measured at specific test conditions. Electrical specifications are not guaranteed over all recommended operating conditions.

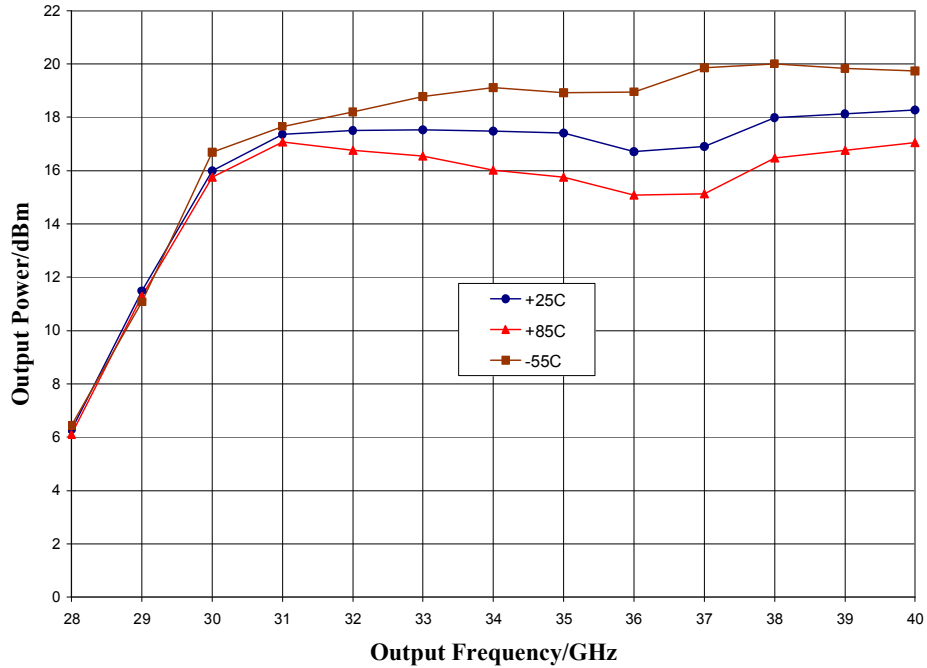
Electrical Specifications - V_{dd} = 5 V, V_{gg1} = -1.8 V, V_{gg2} = -0.7 V, T_A = 25 °C, Pin = 17 dBm

Parameter	Min	Typ	Max	Units
Frequency Range, Input	15 - 20			GHz
Frequency Range, Output	30 - 40			GHz
Output Power	14	17		dBm
Fo Isolation (with respect to output level)	34	46		dBc
Input Return Loss		15		dB
Output Return Loss		7		dB
Supply Current		55		mA

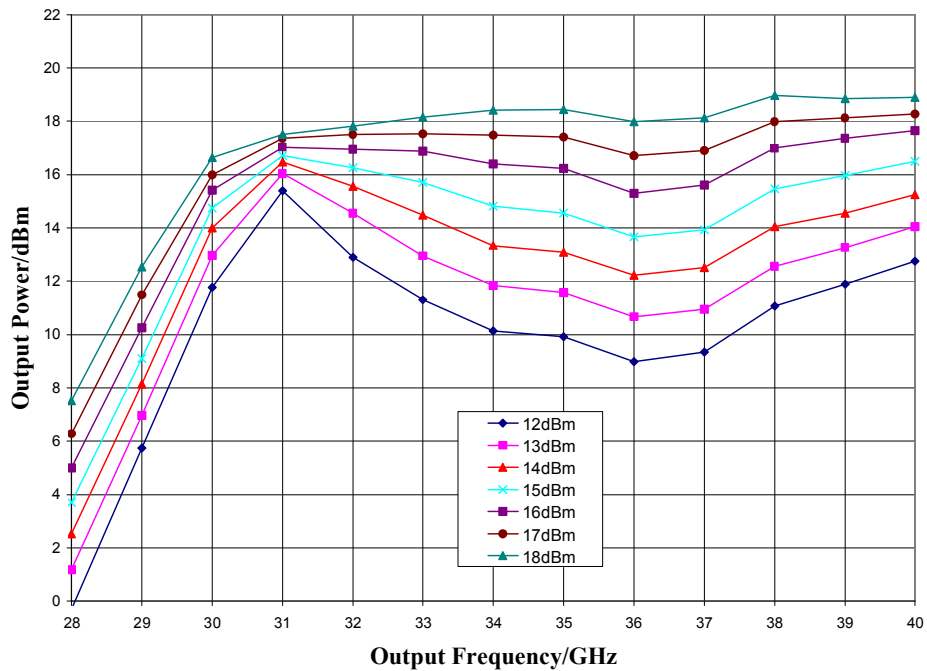
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Typical Performance

Output Power vs. Temperature @ 17 dBm Drive Level



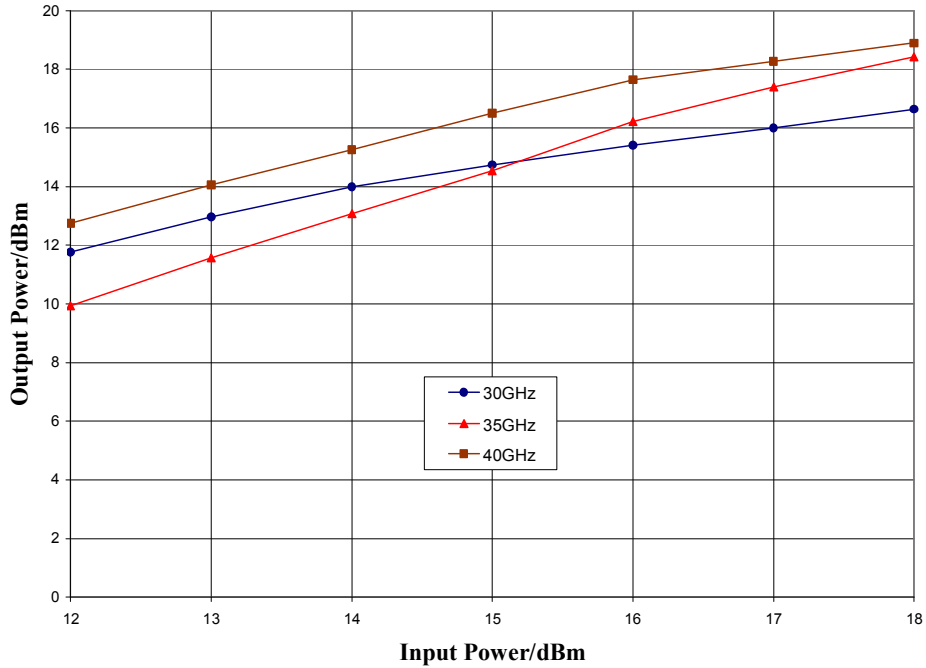
Output Power vs. Drive Level, T_A = 25 °C



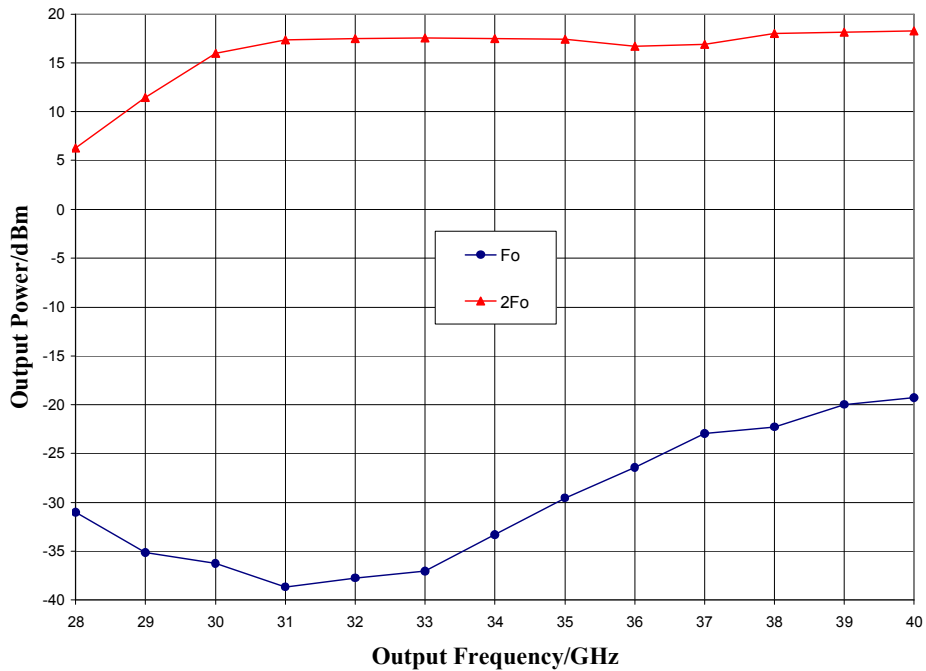
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Typical Performance

Output Power vs. Input Power, $T_A = 25\text{ }^\circ\text{C}$



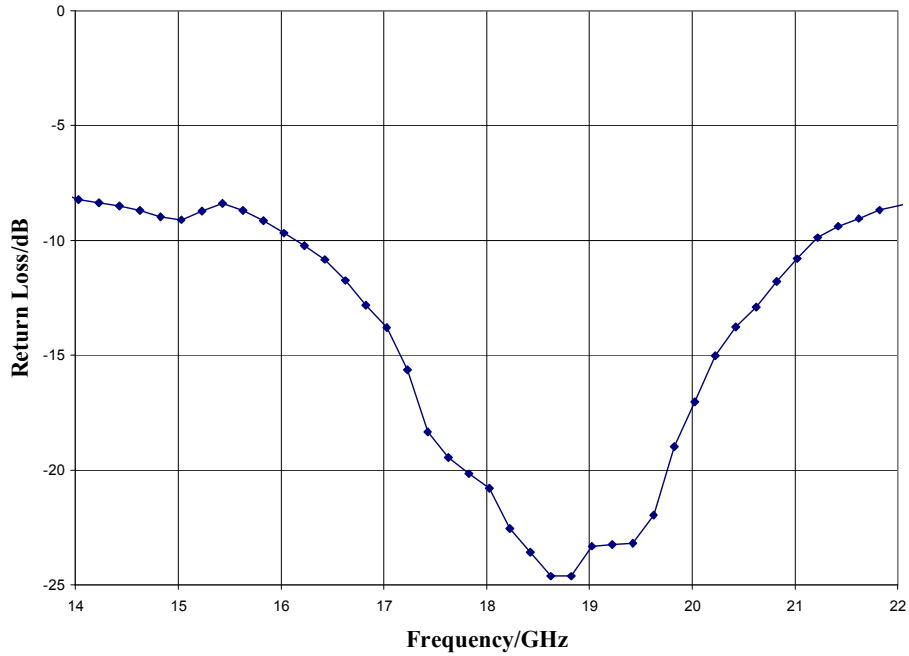
Isolation @ 17 dBm Drive Level, $T_A = 25\text{ }^\circ\text{C}$



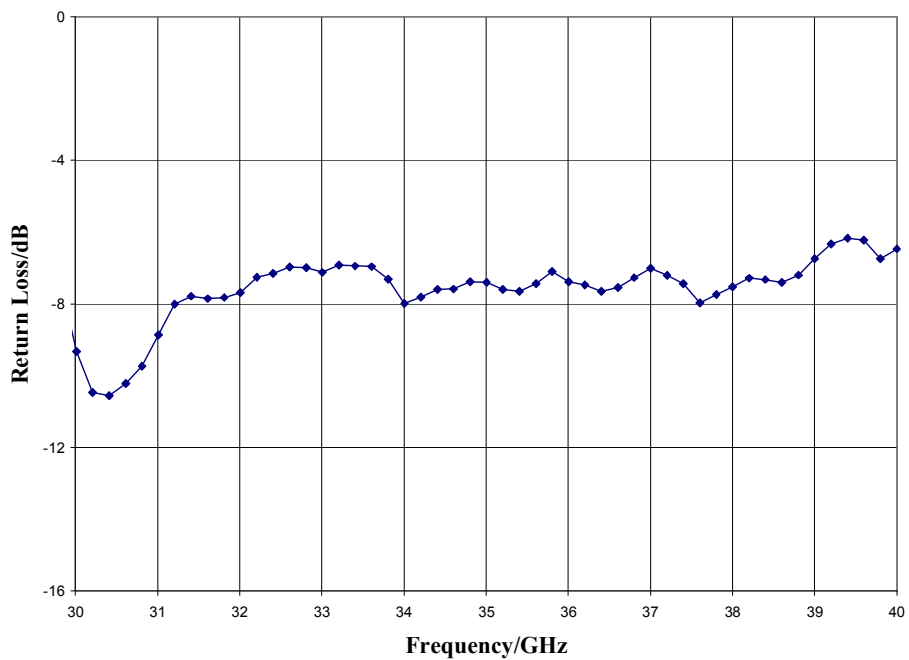
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Typical Performance

Input Return Loss, $T_A = 25\text{ }^\circ\text{C}$



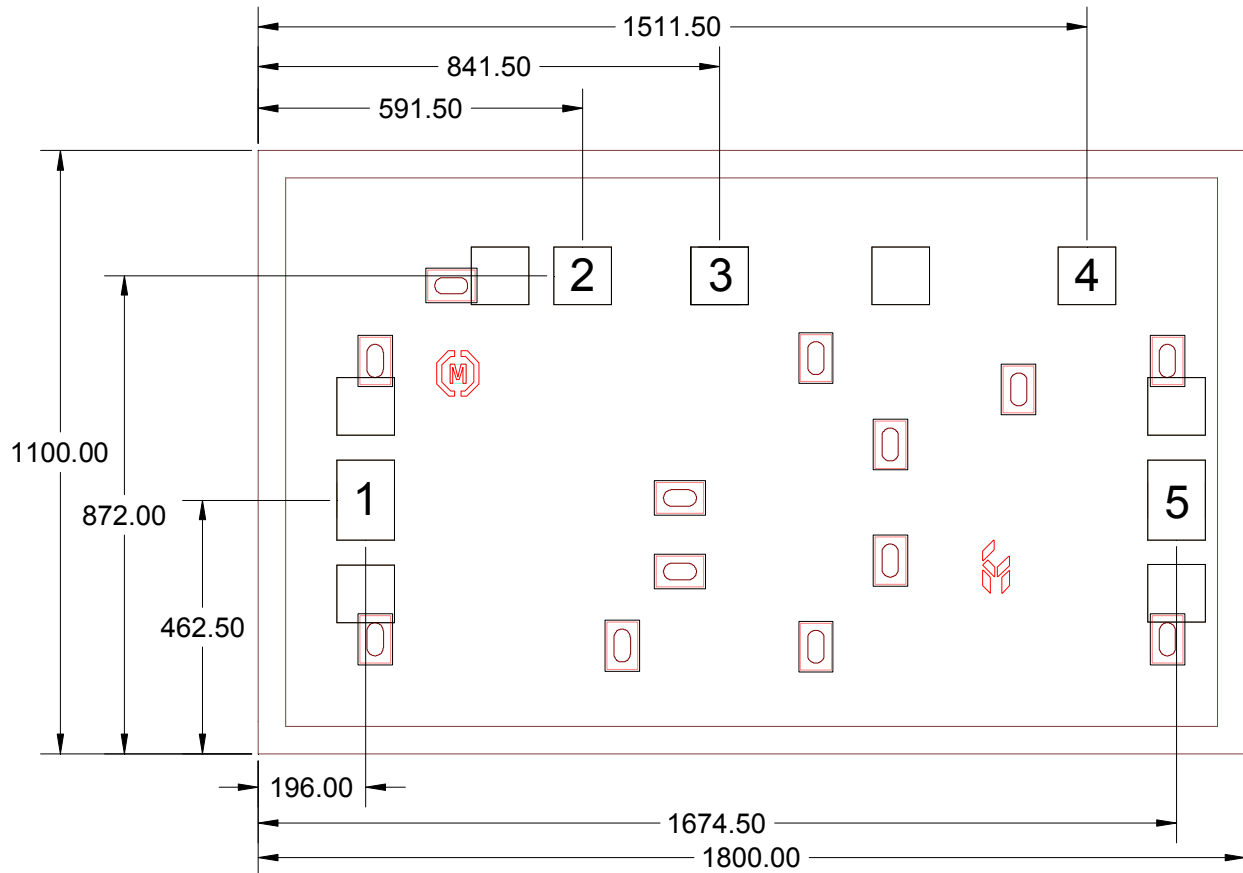
Output Return Loss, $T_A = 25\text{ }^\circ\text{C}$



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Mechanical Information

Die Outline (all dimensions in microns)

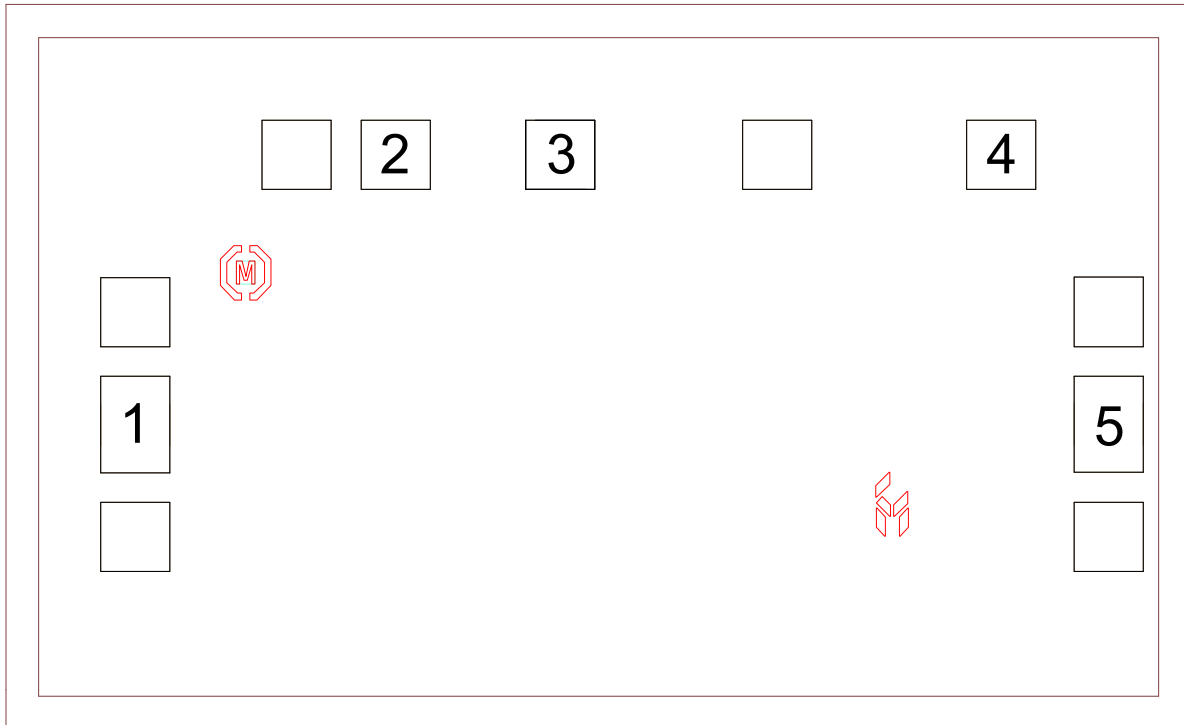


Notes:

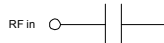
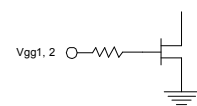
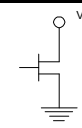


1. No connection required for unlabeled pads
2. Backside is RF and DC ground
3. Backside and bond pad metal: Gold
4. Die is 100 microns thick
5. DC bond pads are 100 microns square

Pin Description

Pad Diagram



Functional Description

Pad	Function	Description	Schematic
1	RF in	DC blocked and 50 ohm matched	
2, 3	V _{gg1, 2}	Power supply voltage Decoupling and bypass caps required	
4	V _{dd}	Power supply voltage Decoupling and bypass caps required	
5	RF out	DC blocked and 50 ohm matched	
Backside	Ground	Connect to RF / DC ground	

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Applications Information

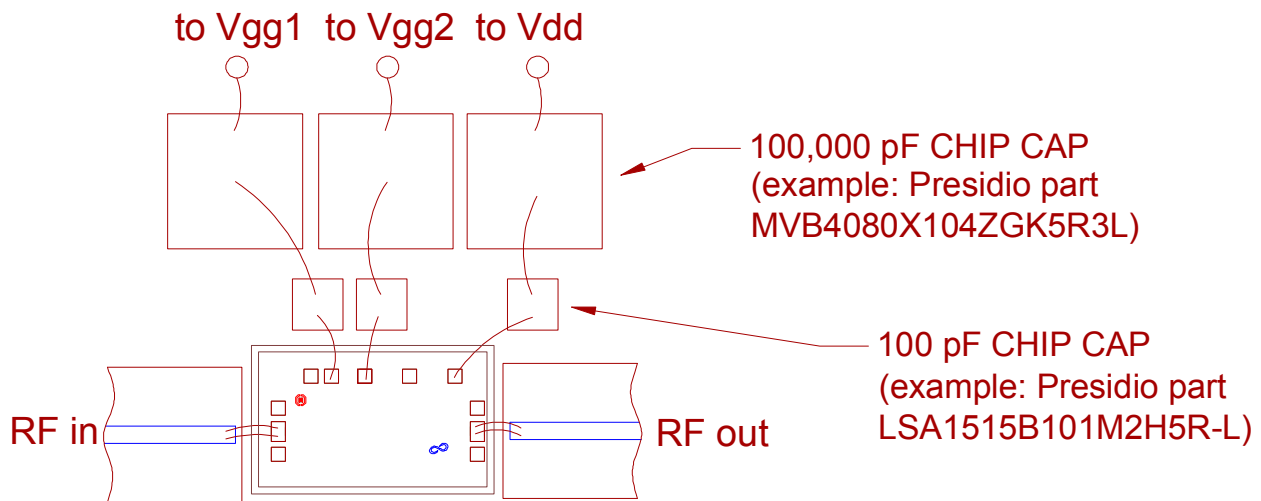
Assembly Guidelines

The backside of the CMD213 is RF ground. Die attach should be accomplished with electrically and thermally conductive epoxy or eutectic attach. Standard assembly procedures should be followed for high frequency devices. The top surface of the semiconductor should be made planar to the adjacent RF transmission lines, and the RF decoupling capacitors placed in close proximity to the DC connections on chip.

RF connections should be made as short as possible to reduce the inductive effect of the bond wire. Use of a 0.8 mil thermosonic wedge bonding is highly recommended as the loop height will be minimized. The RF input and output require a single bond wire as shown.

The semiconductor is 100 μm thick and should be handled by the sides of the die or with a custom collet. Do not make contact directly with the die surface as this will damage the monolithic circuitry. Handle with care.

Assembly Diagram



GaAs MMIC devices are susceptible to damage from Electrostatic Discharge. Proper precautions should be observed during handling, assembly and test.

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Applications Information

Biasing and Operation

The CMD213 is biased with a positive drain supply and two negative gate supplies. Performance is optimized when the V_{dd} is set to +5.0 V, V_{gg1} is set to -1.8 V and V_{gg2} is set to -0.7 V.

Turn ON procedure:

1. Apply gate voltages V_{gg1} and V_{gg2} and set to -1.8 V
2. Apply drain voltage V_{dd} and set to +5 V
3. Adjust gate voltage V_{gg2} and set to -0.7 V

Turn OFF procedure:

1. Turn off drain voltage V_{dd}
2. Turn off gate voltages V_{gg1} and V_{gg2}